## Tender Notification for the procurement of a "Scanning Electron Microscope" at IISc (Last Date for submission of tenders: 3<sup>rd</sup> October 2018)

Dear Sir/Madam,

We are looking for a high-resolution scanning electron microscope (SEM), which can enable us to also perform in situ mechanical testing using an existing micro-mechanical tester (Make: GATAN MTEST 2000EW). For our testing and characterization needs, an SEM with field emission gun (FEG) will be the most suitable and hence we would opt for a FEG SEM if it is financially viable. Since the available budget for the purchase of an SEM is limited, it is reasonable for us to also explore an SEM with LaB<sub>6</sub> source. Nevertheless, we will explore the possibility of purchasing LaB<sub>6</sub> SEM only when we have exhausted all possibility of purchasing FEG SEM. Therefore, we request vendors to submit technical and commercial bids for a FEG SEM and LaB<sub>6</sub> SEM separately (4 cover: 2 technical and 2 financial).

The technical specifications for the SEM are given below, wherein the separate requirements for FEG and LaB<sub>6</sub> SEM's are mentioned wherever needed. Kindly send your best quotation for the same on C.I.P. Bangalore basis. Your quotation should clearly indicate the terms of delivery, delivery schedule, E.D., payment terms etc. For each type of SEM, the tender should be submitted in two separate sealed envelopes - one containing the technical bid and the other containing the commercial bid, both of which should reach us, duly signed on or before 1700 hours 3<sup>rd</sup> October 2018.

Please enclose a compliance certificate along with the technical bid.

Sl.	Feature	Specification	Condition
No.			
1.	Electron source	FEG / LaB <sub>6</sub> *	Mandatory*
	(electron gun)		
2.	Resolution	FEG:	
		3 nm or better @ 30 KV in SE mode	
		4 nm or better @ 5 KV in SE mode	
		4 nm or better @ 30 KV in BSE mode	
		<u>LaB<sub>6</sub>:</u>	
		5 nm or better @ 30 KV in SE mode	
		8 nm or better @ 5 KV in SE mode	
		8 nm or better @30 KV in BSE mode	
3.	Magnification	50X to 500,000X or better	Mandatory
4.	Accelerating	0.1 kV to 30 kV or better	Mandatory
	voltage		
5.	Vacuum system	Fully automated microprocessor controlled	Mandatory
		vacuum system (clarify if any in-built proper	
		safety measures against failure of power	
		supply, vacuum, water-flow, etc. are	
		provided).	
		High vacuum level should be better than 10	

		<sup>5</sup> Pa	
6.	Probe current	FEG:	Mandatory
		1pA to 100 nA or better	
		<u>LaB<sub>6</sub>:</u>	
		1 nA to 1μA or better	
7.	Detector	In lens/in column SE	Mandatory.
		In-lens BSE/ Upper detector	However,
		Chamber mounted SE and BSE detectors	some deviations
			may be allowed
			if functionality
			is not
			compromised.
			Provide
			technical details
			of the detectors,
			especially if
			there is any
			deviation.
8.	Chamber	At least 6 or more accessory ports.	Mandatory,
		Chamber should be equipped with an IR-CCD	with an
		camera or any suitable device to view the	additional note
		sample & stage inside the analysis chamber.	that GATAN
		Equivalent size: $\geq 250 \text{ mm (W)} \times \geq 300 \text{ mm}$	mechanical test
		$(H) \times \ge 250 \text{ mm (D)}$	and heating
		Door size: $\geq 250 \text{ mm (W)} \times \geq 250 \text{ mm (H)}$	system MTEST 2000EW can be
		Anti-vibration support	installed with
			one of the free
			ports (i.e., using
			non-EBSD and
			non-EDS ports)
9.	Specimen Stage	X = at least 150 mm or more	Mandatory,
<i>)</i> .	Specificin Stage	Y = at least 150 mm or more	with additional
		Z =at least 50 mm or more	note that
		Tilt = $-3$ to $70^{\circ}$ or better	GATAN
		Rotation = 360°	mechanical test
		Control of stage movement should be	and heating
		controllable through both computer and	system MTEST
		manual with joystick.	2000EW should
			be able to be
			installed and
			used for EBSD
			measurements

	T	I	
			(i.e., x, y, z
			movement, tilt
			and rotation
			capability
			should not be
			affected up to 2
			kg weight on
			stage)
10.	Compatibility	Both Chamber and stage configuration should	Mandatory
	for in-situ	be compatible to installing in-situ testing	
	testing and	(mechanical test and heating) system of	
	heating	GATAN(Model #: MTEST2000EW; Sys	
	_	Serial #: MT10710), which is already existing	
		the PI's lab.	
		Functionality up to 600 °C or higher	
11	Scanning	Fastest rate of 50 ms for 1 mega pixel or	Mandatory
		better	Optional: Video
		Maximum image resolution of 20 mega pixel	recording
		or better	capability
12.	Display and	24" or higher TFT monitor(s) for image	Mandatory
	output	processing	•
		CPU: Minimum 1tb hd capacity	
		Latest compatible branded high-speed	
		computer with preloaded licensed software for	
		SEM operating parameters.	
		Servicing facility for computer related	
		problems should be provided.	
		Specify computer speed, processor, RAM and	
		graphics card. All the computers for SEM,	
		EDS-EBSD must be imported factory fitted	
		and tested with pre-loaded softwares for	
		operating these systems.	
13.	Warranty	One year of comprehensive on-site warranty.	Mandatory
		y successive on one manning.	Optional: 2
			years of
			additional
			comprehensive
			on-site
			warranty)
14.	Installation	Pre-installation requirements such as room	Mandatory
14.	requirement	size, tolerable limits of EM field and vibration	ivianuaioi y
	requirement	(mechanical), required power rating, utility	
		requirements are to be stated clearly, and to be	
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verified/surveyed by the supplier at the installation site. It is the supplier's responsibility to clearly provide details of the above-mentioned requirements before delivery of the equipment.

Necessary environmental requirements, i.e.,

Necessary environmental requirements, i.e., temperature, humidity etc during the operation of SEM should be specified clearly. The operator should be not only trained in operating but also know the installation requirements for smooth uninterrupted functioning of the SEM

\*Please quote separately for FEG source and LaB6 source. First all technical specs for FEG SEM will be opened. If all the parameters of specification comply, then the financial bidsfor FEG SEM will be opened, and the lowest priced quote will be considered. If none of the quotes are found suitable financially, then the technical specs with LaB6 SEM will be opened. If all the parameters of specification comply, then the financial bid for LaB6 SEM will be opened, and the lowest priced quote will be considered.

## **Acceptance criterion:**

Demonstration of all aforementioned technical specifications on site after installation

## **Terms & conditions**

- 1. Price for all other upgrades such as "addition of EDS and EBSD" may also be given. These will be procured at a later date as and when required. The vendor should also make sure that the price quoted would be valid for a period of 2 years. Reasonable change in the price will be accepted.
- 2. Two-bid system (separate technical and financial bids in this case 2 technical and 2 financial bids, making it total 4) in sealed tenders.
- 3. The technical bid must clearly specify the prescribed technical specifications without including the prices. Please provide in detail the specifications under the above subheads. Unique characteristics may be highlighted. Vendors who include price information in the technical bids will be automatically disqualified.
- 4. Technical bids will be opened first. IISc may seek clarifications after opening of technical bids, and may ask them to perform some example experiments on the sample given by IISc to demonstrate the promised technical specifications. Vendors may be required to give presentations. There are several items that require information to be provided by the supplier. If information is not provided against any of these items, this will disqualify the supplier. After technical evaluation by a committee, vendors may be asked to re-quote in a specific format to facilitate comparison of prices. IISc also reserves the right to cancel the tender at any time without assigning any reason whatsoever.
- 5. Price bids of only technically qualified vendors will be considered, and the vendors will be informed the day of opening the price bids.

- 6. The price bids must offer CIF Bangalore prices.
- 7. Prices to be quoted separately for baseline system and options. Prices will should be quoted in adequate detail with relation to packing details to cover insurance compensation in case of damage to any specific modules
- 8. Indicate separately price of spares listed above in terms of unit cost. The price of these spares will be included in the price comparison. Any additional spares recommended by the company will be considered for ordering but not included in the comparison. The buyer reserves the right to make the final decision on ordered spares
- 9. Indicate price for annual maintenance contract.
- 10. The payment will be by letter of credit: payable 80% on shipping, 20% after satisfactory installation and acceptance.
- 11. Indicate delivery period
- 12. Order will be placed on lowest bid from technically qualified vendor
- 13. The tender documents can be sent at the following address:

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